

INTERNATIONAL CONTROL SYSTEMS CONFERENCE

APRIL 26-29, 2026 • COLUMBUS, OHIO




Co-located with TAPPICon

PROGRAM

[Compact, ver. April 1.]

Monday 27.	AI / Data Analytics [GCCC – Room A122/123]
13:00 – 15:00	Seyhan Nuyan, Retired (formerly with Valmet) & Mariana Sandin, SEEQ
13:00 – 13:30	Agentic AI's Impact on Operating Models Michael Vasicek, Kyndryl
13:30 – 14:00	Encoding the SME: AI for Accelerated Learning in Complex Operations Philip Pierce, SEEQ
14:00 – 14:30	Enhancing Mill Operations: Automation and Analytics within the PDCA Framework Matti Hakkinen, Trimble
14:30 – 15:00	AI in the Mill: From Gut Feel to Evidence Mariana Sandin, SEEQ
Monday 27.	Mill Automation – Dewatering and Moisture Management [GCCC – Room A120/121]
16:00 – 17:30	Shih-Chin Chen, Retired (formerly with ABB, Inc.) & Rick Wasson, Irving Paper & Melanie Toups, Jacobs
16:00 – 16:30	Closed-Loop Vacuum Control in Papermaking: A Data-Driven Approach to Wet End Optimization Luca Canali, S.A. & Giuseppe Cristini S.p.A.
16:30 – 17:00	Airflow-based Vacuum Control for Optimizing Felt Dewatering Petteri Halme, Valmet Technologies, Inc.
17:00 – 17:30	Enhanced Paper Machine Controls and Process Optimization with LWIR Cameras Slawek Frackowiak, Industrial Video Solutions & Mickey Held, Honeywell
Tuesday 28.	Paper Machine Measurement and Control [GCCC – Room A122/123]
08:00 – 10:00	Michael Forbes, Honeywell
08:00 – 08:30	Cell Configurations in the ANOVA Interaction Model to Identify Two-Dimensional Patterns in Reel Data Kerry Figiel, OnCareDA
08:30 – 09:00	Towards Process Excellence: Advanced Optimization of Grade Change Operations in Paper Manufacturing Abhay Anand, ABB Limited
09:00 – 09:30	Paper Color Control: Adaptive Modeling and Predictive Strategies for Optimality and Robustness Calvin Fu, Valmet & Seyhan Nuyan, Retired (formerly Valmet)
Tuesday 28.	Measurement Correlations [GCCC – Room A122/123]
10:00 – 11:30	Lu Athnos, ABB Inc.
10:00 – 10:30	Standardized Dynamic Correlation Practices for Online Sensors Lu Athnos, ABB Inc.
10:30 – 11:00	Caliper Dynamic Correlation – Single Point Method (TIP 1101-10) Mike Butynski, ABB
11:00 – 11:30	Fresh Look at Online-to-Offline Measurement Correlation from a Soft Sensor Perspective Shih-Chin Chen, Retired (formerly with ABB, Inc.)
Tuesday 28.	Process Control General [GCCC – Room A122/123]
13:30 – 15:00	Kerry Figiel, OnCareDA

13:30 – 14:00	Increasing Stability with Adaptive Parabolic Algorithm Control Douglas McCallum, McCallum Value Partners
14:00 – 14:30	Beyond Retuning: A Disciplined and Lightweight Program for Sustained Control Loop Health Ian Journeaux, Envoy Development, LLC
14:30 – 15:00	OT Networks and Cybersecurity in Plain Language Scott McNeil
Tuesday 28.	Pulp Mill Operations (CSC) [GCCC – Room A122/123]
16:00 – 17:30	Antonio Suarez, Smurfit WestRock
16:00 – 16:30	Transitions for Pulp Mills Ramesh Satini, ABB Pte Ltd.
16:30 – 17:00	Kraft Lab Liquor Testing Advancements James Goldman, FITNIR
17:00 – 17:30	Control of Continuous Digester Kappa Number Using Generalized Model Predictive Control Wesley Gilbert, FPIInnovations
Wednesd 29.	Operator Training & Interface Experience [GCCC – Room A110/111]
10:00 – 12:00	Katarina Bodor, ABB & Mariana Sandin, Seeq
10:00 – 10:30	Preventing Console Overload David Strobhar, Beville Engineering Inc.
10:30 – 11:00	The Control-Room Co-Pilot: Deploying an AI Assistant That Explains, Watches, and Suggests— Without Taking the Joystick Gordon Jones, Envoy Development, LLC
11:00 – 11:30	When Realism Meets ROI: Selecting the Right Fidelity for an Operator Training System Drew Habel, Jedson Engineering
11:30 – 12:00	Grade Change Performance Assessment Through Digital, Persona-Centric Dashboards Maya Manish, ABB Inc.
Wednesd 29.	Cybersecurity, Safety, and Machine Vision Applications [GCCC – Room A112/113]
13:00 – 15:00	Brian Mock, Event Capture Systems Inc.
13:00 – 13:30	Old Machines, New Threats: Can Cyber Hygiene Modernize Paper Mill Security? Sourav Kunal, ABB Inc.
13:30 – 14:00	Bridging Safety and Process Control: AI Enabled Real-Time Pinch Zone Hazard Mitigation Matthew Goethel, Detect Technologies USA Inc. & Lorell Carter-Walker, International Paper
14:00 – 14:30	AI-Driven Computer Vision Framework for Compositional Classification and Quality Assessment of Reco Mariangeles Scalas, North Carolina State University
14:30 – 15:00	Improved Quality Inspection for Food and Liquid Packaging Board Using 3D and UV Detection Alex Poltorak, Procemex, Inc.

	This is the link to the on-line page for this pgm. [https://www.handix.se/cs-2026]		Link to the TappiCon on-line conference registration page. [https://events.tappi.org/event/tappicon/regProcessStep1]		For info about the conference, the venue and Columbus, Ohio, [https://events.tappi.org/event/tappicon/control-systems-conference]
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International Program Committee
The final scientific content, invited lectures, panels, and sessions for the conference has been developed with the assistance of the International Program Committee consisting of professionals from North America, Europe and Asia.

The organizers
include representatives from the leading technical associations within the North American and Nordic pulp and paper industries, namely TAPPI, PAPTAC, SPCI, and PI.

